



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

SZSAR-TRF-01-A01 Rev. A/1 Aug 16, 2024

Report No.: SZCR251200552601

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Appendix C

Calibration certificate

1. Dipole
D2450V2-SN 733
2. DAE
DAE4-SN 760
3. Probe
EX3DV4-SN 3836



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Client **SGS (Shenzhen)**

Certificate No: **25J02Z000729**

CALIBRATION CERTIFICATE

Object **D2450V2 - SN: 733**

Calibration Procedure(s) **FF-Z11-0003-02**
Calibration Procedures for dipole validation kits

Calibration date: **October 15, 2025**

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	106276	16-May-25 (CTTL, No. 25J02X003423)	May-26
Power sensor NRP6A	101369	16-May-25 (CTTL, No. 25J02X003423)	May-26
Reference Probe EX3DV4	SN 7464	28-Jan-25(SPEAG, No. EX-7464_Jan25)	Jan-26
DAE4	SN 1588	29-Aug-25(CTTL-SPEAG, No. 25J02Z000631)	Aug-26
Secondary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
SignalGeneratorSMA200A	107732	22-Jan-25 (CTTL, No. 25J02X000388)	Jan-26
NetworkAnalyzer E5071C	MY46110673	18-Dec-24 (CTTL, No. 24J02X103932)	Dec-25
OCP DAK-3.5	1040	20-Jan-25(SPEAG, No. OCP-DAK3.5-1040_Jan25)	Jan-26

	Name	Function	Signature
Calibrated by:	Zhao Jing	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: October 21, 2025

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM _{x,y,z}
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure for The Assessment of Specific Absorption Rate of Human Exposure to Radio Frequency Fields from Hand-held and Body-mounted Wireless Communication Devices- Part 1528: Human Models, Instrumentation and Procedures (Frequency range of 4 MHz to 10 GHz)", October 2020
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

- DASY System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY6	V17.0.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 5 mm, dz = 1.5 mm	Graded Ratio = 1.5 (Z direction)
Frequency	2450 MHz $\pm$ 1 MHz	

Head TSL parameters at 2450 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	39.0 $\pm$ 6 %	1.78 mho/m $\pm$ 6 %
Head TSL temperature change during test	<1.0 °C	----	----

SAR result with Head TSL at 2450 MHz

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	24 dBm input power	12.9 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	51.9 W/kg $\pm$ 20 % (k=2)
SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR measured	24 dBm input power	6.10 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.5 W/kg $\pm$ 20 % (k=2)

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Appendix (Additional assessments outside the scope of CNAS L0570)

Antenna Parameters with Head TSL at 2450 MHz

Impedance, transformed to feed point	52.5Ω+ 4.99jΩ
Return Loss	- 25.3dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.056 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feed-point can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.
 No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feed-point may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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DASY6 Validation Report for Head TSL
 Test Laboratory: CTTL, Beijing, China

Date: 2025-10-15

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D2450V2 – SN 733	2450	HSL	24

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band Group, UID	Frequency [MHz]	Conversion Factor	TSL Cond. [S/m]	TSL Permittivity
Flat	10	CW,	2450	6.89	1.78	39.0

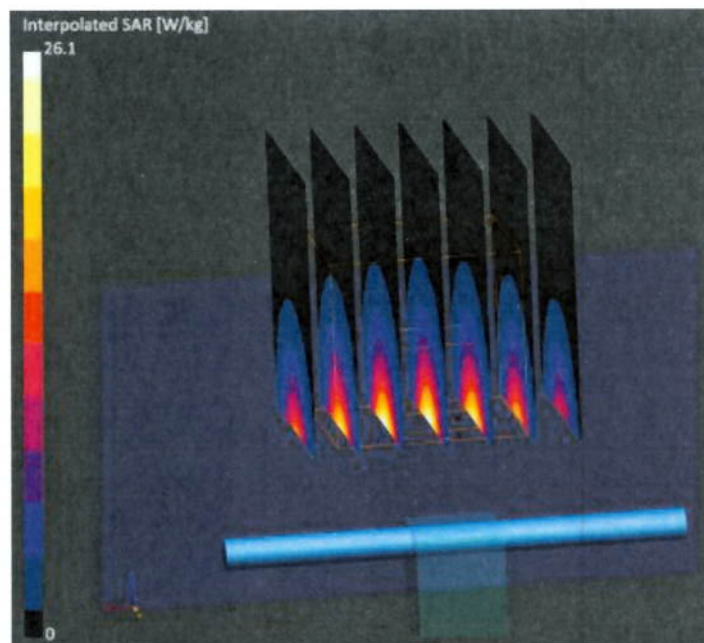
Hardware Setup

Phantom	TSL	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Right	2450 Head	EX3DV4 - SN7464, 2025-01-28	DAE4 Sn1588, 2025-08-29

Scan Setup

Measurement Results

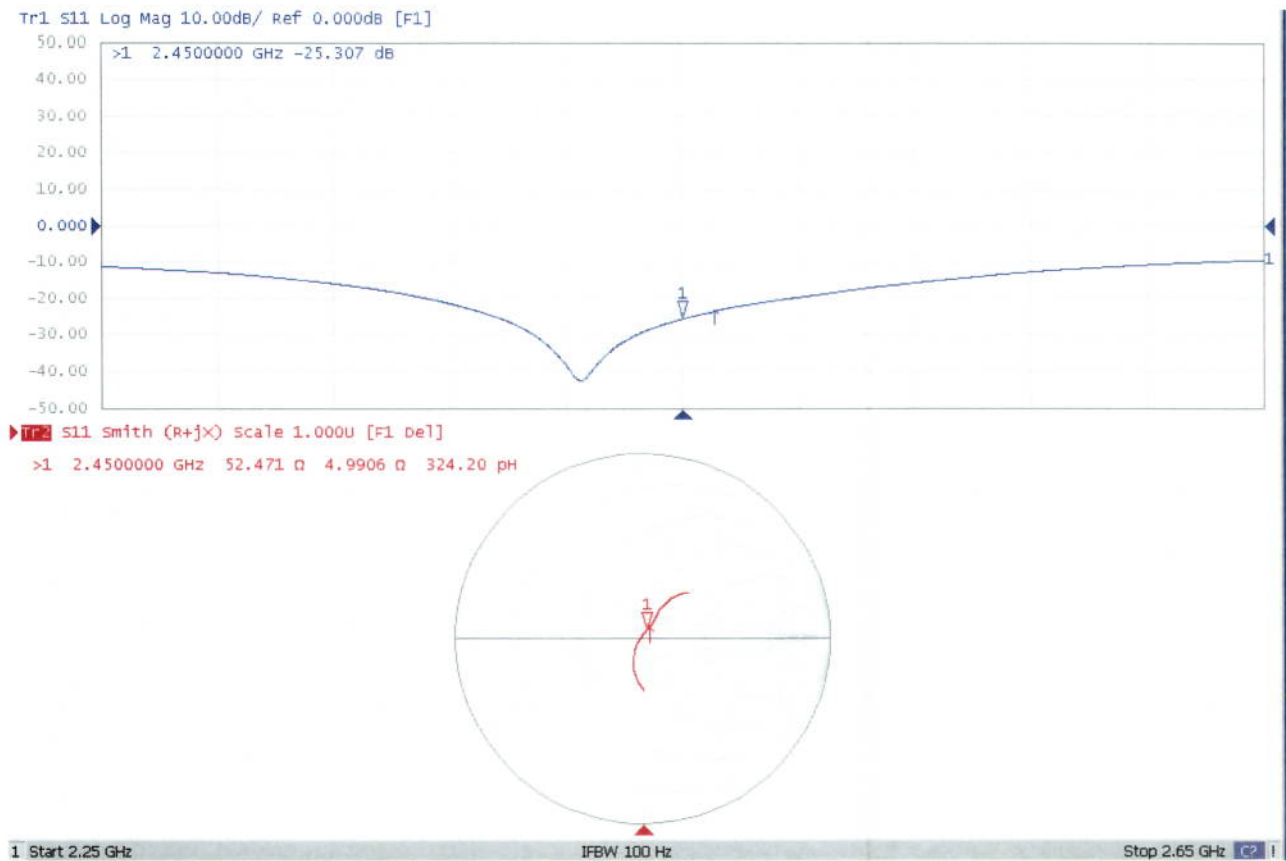
Zoom Scan		Zoom Scan	
Grid Extents [mm]	30.0×30.0×30.0	psSAR1g [W/kg]	12.9
Grid Steps [mm]	5.0×5.0×1.5	psSAR10g [W/kg]	6.10
Sensor Surface [mm]	1.4	Power Drift [dB]	-0.01
Graded Grid	Yes	Power Scaling	Disabled
Grading Ratio	1.5	Scaling Factor [dB]	
MAIA	N/A	TSL Correction	No correction
Surface Detection	VMS + 6p	M2/M1 [%]	81.5
Scan Method	Measured	Dist 3dB Peak [mm]	9.0





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Impedance Measurement Plot for Head TSL



Client: **SGS**
Shenzhen

Certificate No: **25J02Z000645**

CALIBRATION CERTIFICATE

Object **DAE4 - SN: 760**

Calibration Procedure(s) **FF-Z11-002-01**
Calibration Procedure for the Data Acquisition Electronics (DAEx)

Calibration date: **August 29, 2025**

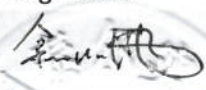
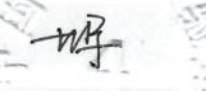
This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)℃ and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
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Process Calibrator 753	1971018	11-Jun-25 (CTTL, No.25J02X004977)	Jun-26
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	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: August 30, 2025

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Glossary:

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other performance test results.



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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.769 $\pm$ 0.15% (k=2)	404.989 $\pm$ 0.15% (k=2)	405.298 $\pm$ 0.15% (k=2)
Low Range	3.95794 $\pm$ 0.7% (k=2)	3.99297 $\pm$ 0.7% (k=2)	3.98079 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	20.5° $\pm$ 1 °
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Client

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Certificate No: 25J02Z000891

CALIBRATION CERTIFICATE

Object EX3DV4 - SN : 3836

Calibration Procedure(s) FF-Z11-0004-03
Calibration Procedures for Dosimetric E-field Probes

Calibration date: December 19, 2025

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	106277	20-Oct-25(CTTL, No.25J02X100272)	Oct-26
Power sensor NRP8S	104291	20-Oct-25(CTTL, No.25J02X100272)	Oct-26
Power sensor NRP8S	104292	20-Oct-25(CTTL, No.25J02X100272)	Oct-26
Reference 10dBAttenuator	18N50W-10dB	22-Jan-25(CTTL, No.25J02X000465)	Jan-27
Reference 20dBAttenuator	18N50W-20dB	22-Jan-25(CTTL, No.25J02X000466)	Jan-27
Reference Probe EX3DV4	SN 7307	27-May-25(SPEAG, No.EX-7307_May25)	May-26
DAE4	SN 771	22-Jan-25(SPEAG, No.DAE4-771_Jan25)	Jan-26
Secondary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
SignalGenerator MG3700A	6201052605	10-Jun-25(CTTL, No.25J02X004975)	Jun-26
SignalGenerator APSIN26G	181-33A6D0700-1959	27-Mar-25(CTTL, No.25J02X001962)	Mar-26
Network Analyzer E5071C	MY46110673	26-Nov-25(CTTL, No.25J02X102468)	Nov-26
Reference 10dBAttenuator	BT0520	15-May-25(CTTL, No.25J02X003069)	May-27
Reference 20dBAttenuator	BT0267	15-May-25(CTTL, No. 25J02X003070)	May-27
OCP DAKS-3.5	SN 0015	20-Oct-25(SPEAG, No. OCP-DAKS-0015_Oct25)	Oct-26

	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: December 23, 2025

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Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i $\theta=0$ is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- IEC 62209-1, "Measurement procedure for the assessment of Specific Absorption Rate (SAR) from hand-held and body-mounted devices used next to the ear (frequency range of 300 MHz to 6 GHz)", July 2016
- IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\theta=0$ ($f \leq 900\text{MHz}$ in TEM-cell; $f > 1800\text{MHz}$: waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR:** PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}:** A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800\text{MHz}$) and inside waveguide using analytical field distributions based on power measurements for $f > 800\text{MHz}$. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from $\pm 50\text{MHz}$ to $\pm 100\text{MHz}$.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle:** The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).



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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3836

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc ($k=2$)
Norm($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.40	0.45	0.44	$\pm 10.0\%$
DCP(mV) ^B	93.9	99.6	98.2	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Unc ^E ($k=2$)
0	CW	X	0.0	0.0	1.0	0.00	144.4	$\pm 2.0\%$
		Y	0.0	0.0	1.0		160.6	
		Z	0.0	0.0	1.0		157.9	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E^2 -field uncertainty inside TSL (see Page 4).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3836

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.23	9.23	9.23	0.09	1.74	± 13%
835	41.5	0.90	8.85	8.85	8.85	0.10	1.59	± 13%
1750	40.1	1.37	7.95	7.95	7.95	0.19	1.07	± 13%
1900	40.0	1.40	7.60	7.60	7.60	0.23	1.04	± 13%
2100	39.8	1.49	7.58	7.58	7.58	0.18	1.18	± 13%
2300	39.5	1.67	7.50	7.50	7.50	0.48	0.70	± 13%
2450	39.2	1.80	7.24	7.24	7.24	0.43	0.75	± 13%
2600	39.0	1.96	7.07	7.07	7.07	0.50	0.71	± 13%
3300	38.2	2.71	6.75	6.75	6.75	0.42	0.92	± 14%
3500	37.9	2.91	6.62	6.62	6.62	0.40	1.03	± 14%
3700	37.7	3.12	6.41	6.41	6.41	0.42	1.01	± 14%
3900	37.5	3.32	6.32	6.32	6.32	0.30	1.50	± 14%
4100	37.2	3.53	6.25	6.25	6.25	0.30	1.40	± 14%
4400	36.9	3.84	6.06	6.06	6.06	0.30	1.50	± 14%
4600	36.7	4.04	5.98	5.98	5.98	0.35	1.48	± 14%
4800	36.4	4.25	5.97	5.97	5.97	0.40	1.35	± 14%
4950	36.3	4.40	5.80	5.80	5.80	0.40	1.35	± 14%
5250	35.9	4.71	5.22	5.22	5.22	0.40	1.53	± 14%
5600	35.5	5.07	4.65	4.65	4.65	0.45	1.40	± 14%
5750	35.4	5.22	4.77	4.77	4.77	0.45	1.40	± 14%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

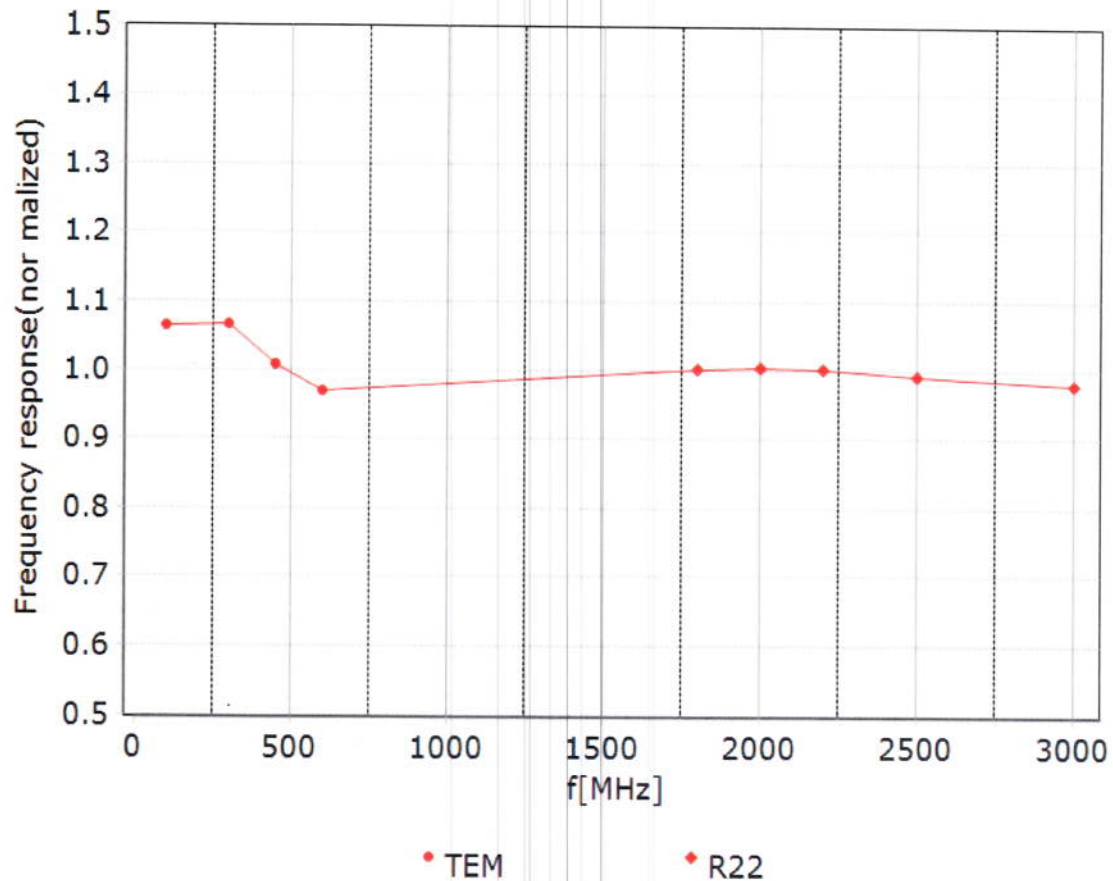
^F At frequency up to 6 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.



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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 7.4\%$ ($k=2$)

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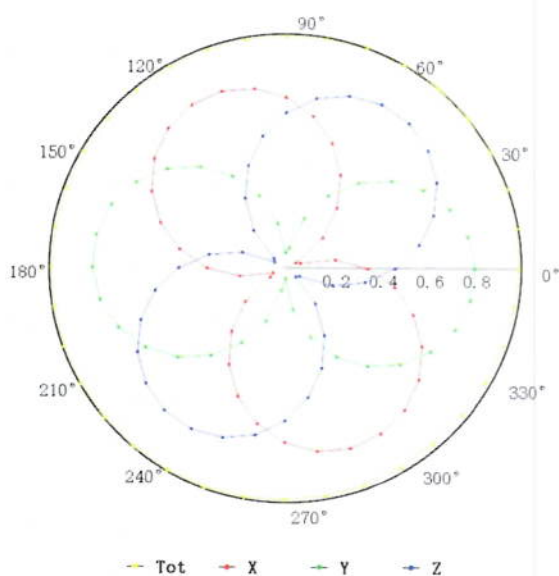
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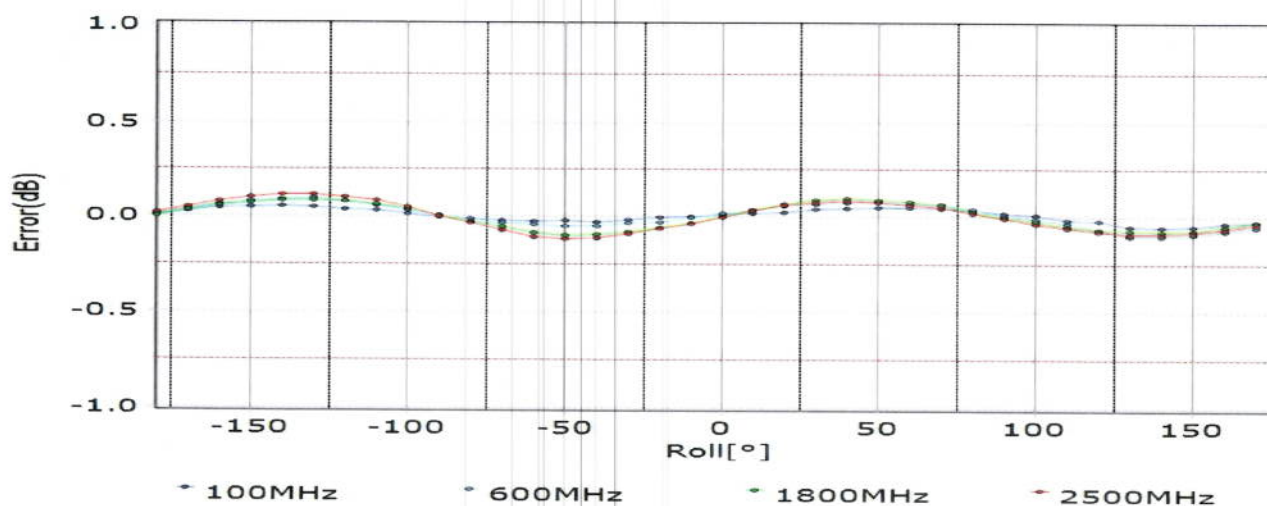
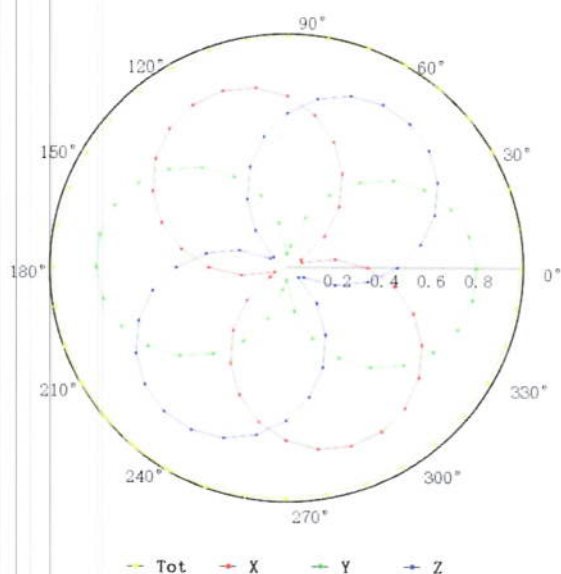
http://www.caict.ac.cn

Receiving Pattern (Φ), $\theta=0^\circ$

f=600 MHz, TEM



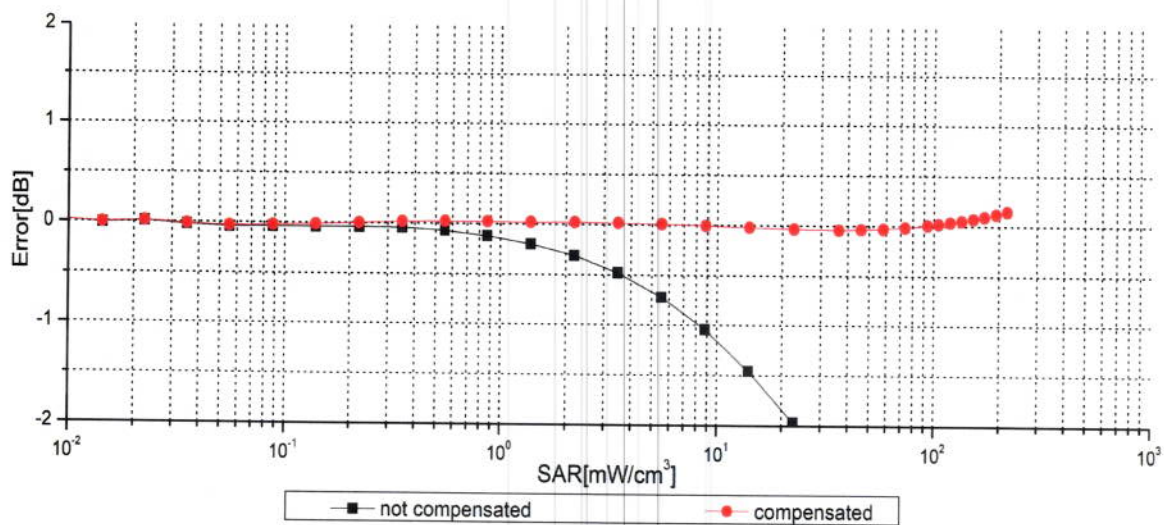
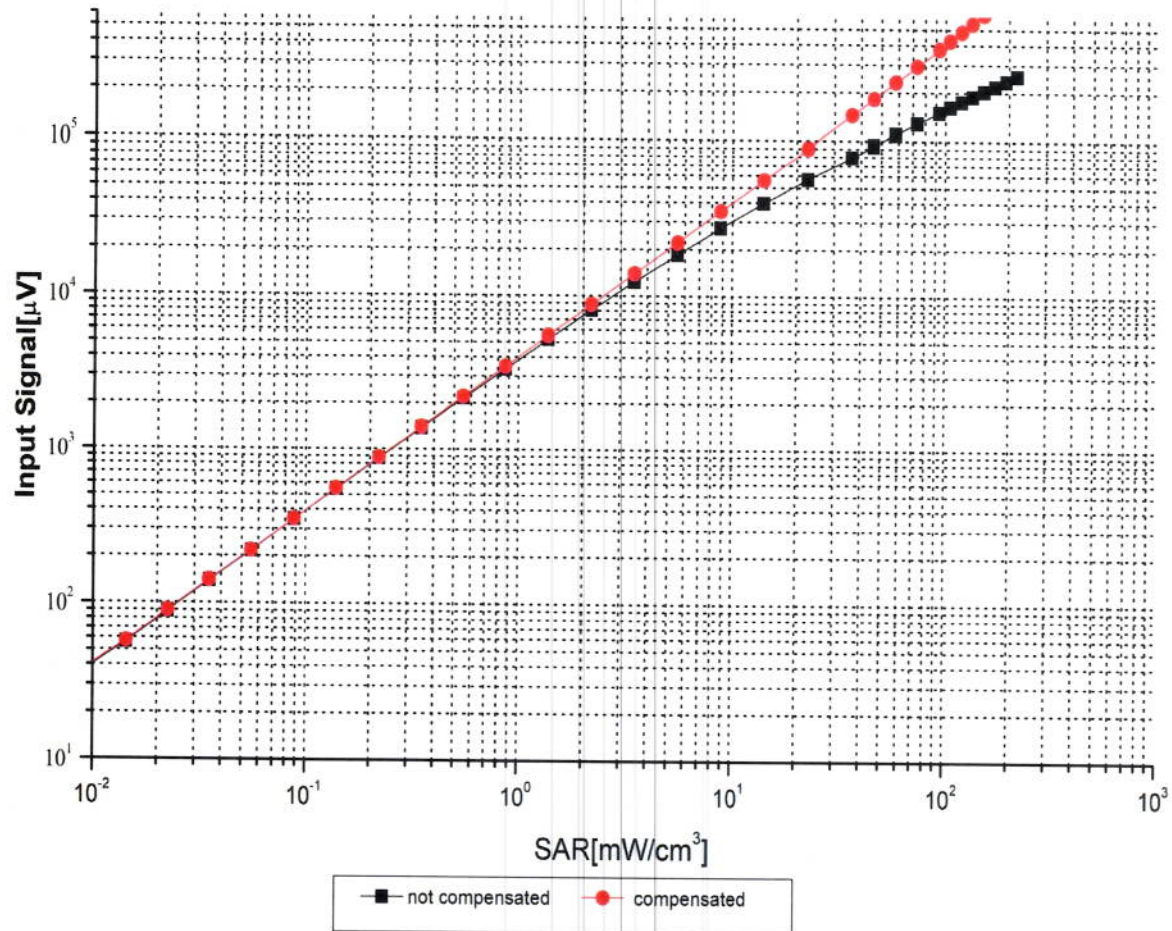
f=1800 MHz, R22



Uncertainty of Axial Isotropy Assessment: $\pm 1.2\%$ ($k=2$)

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Dynamic Range f(SAR_{head}) (TEM cell, f = 900 MHz)

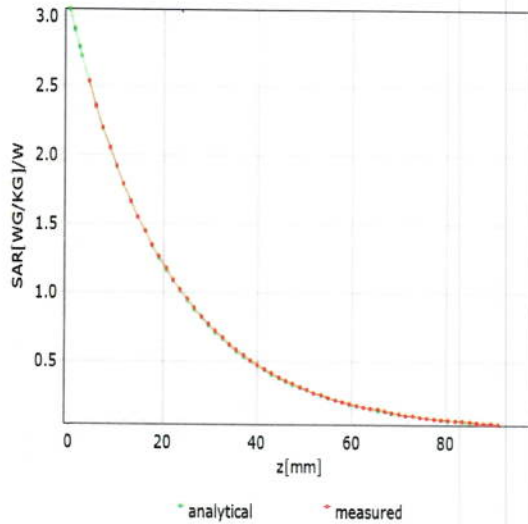


Uncertainty of Linearity Assessment: ±0.9% (k=2)

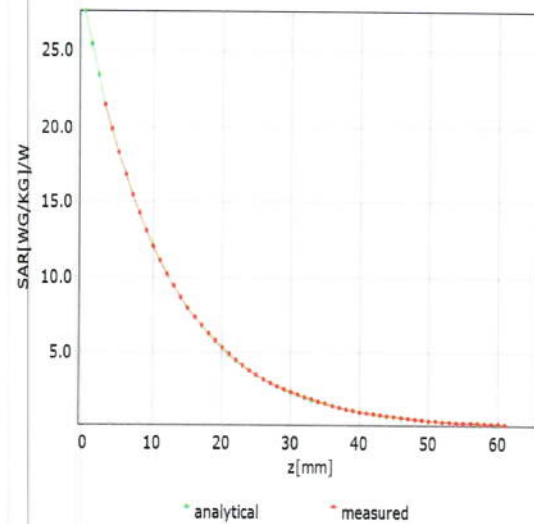
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Conversion Factor Assessment

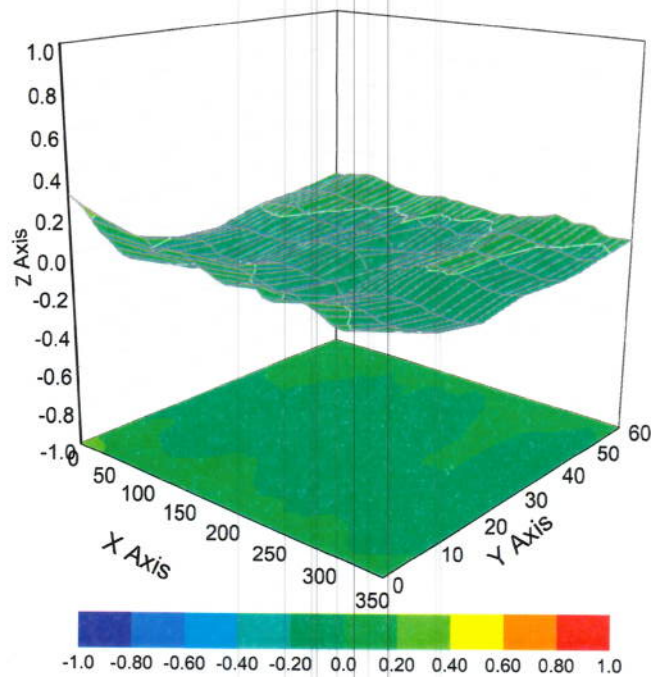
f=750 MHz,WGLS R9(H_convF)



f=1750 MHz,WGLS R22(H_convF)



Deviation from Isotropy in Liquid



Uncertainty of Spherical Isotropy Assessment: $\pm 3.2\%$ ($k=2$)



In Collaboration with

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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3836

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	47
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

SZSAR-TRF-01-A01 Rev. A/1 Aug 16, 2024

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- End of Appendix -



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Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

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